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| INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) | ATTY DOCKET NO. 458/04234 | SERIAL NO. 10/686,914 |
| | APPLICANT(S) Erez YAHALOMI | |
| | FILING October 14, 2003 | GROUP 2826 |

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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OTHER DOCUMENTS (Including Author, Title, Date Pertinent Pages, Etc.)

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|-----|----|---|
| Suu | 1. | FIELD, M. et al; "Measurements of Coulomb Blockade with a Noninvasive Voltage Probe"; Physical Review Letters, Vol. 70, No. 9; pp. 1311-1314; March 1, 1993. |
| Suu | 2. | YAHALOMI, E. M.; "Decrease of Particle's Interference Pattern Due to Energy Changes"; September 5, 2001; Retrieved from the Internet at <http://arxiv.org/abs/physics/0109013>; 15 Pages. |
| Suu | 3. | YAHALOMI, E.; "Electron Wave Function Distribution Change in Mesoscopic Systems"; October 7, 2003; Retrieved from the Internet at <http://arxiv.org/abs/cond-mat/0310144>; 11 Pages. |

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| EXAMINER <i>Suu</i> | DATE CONSIDERED 2-14-2005 |
| *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | |

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